#### OBSOLETE - No Longer Available

# TIBPAL20L8-7C, TIBPAL20R4-7C, TIBPAL20R6-7C, TIBPAL20R8-7C TIBPAL20L8-10M, TIBPAL20R4-10M, TIBPAL20R6-10M, TIBPAL20R8-10M HIGH-PERFORMANCE *IMPACT-X* ™ *PAL*<sup>®</sup> CIRCUITS

C S

SRPS005E - D3307, OCTOBER 1989 - REVISED DECEMBER 2010

TIBPAL20L8'

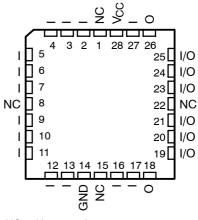
- High-Performance Operation: f<sub>max</sub> (no feedback) TIBPAL20R' -7C Series . . . 100 MHz TIBPAL20R' -10M Series . . . 62.5 MHz f<sub>max</sub> (internal feedback) TIBPAL20R' -7C Series . . . 100 MHz TIBPAL20R' -10M Series . . . 62.5 MHz f<sub>max</sub> (external feedback) TIBPAL20R' -7C Series . . . 74 MHz TIBPAL20R' -10M Series . . . 50 MHz Propagation Delay TIBPAL20L8-7C Series . . . 7 ns Max TIBPAL20L8-10M Series . . . 10 ns Max
- Functionally Equivalent, but Faster Than Existing 24-Pin PLD Circuits
- Preload Capability on Output Registers Simplifies Testing
- Power-Up Clear on Registered Devices (All Register Outputs are Set Low, but Voltage Levels at the Output Pins Go High)
- Package Options Include Both Plastic and Ceramic Chip Carriers in Addition to Plastic and Ceramic DIPs
- Security Fuse Prevents Duplication
- Dependable Texas Instruments Quality and Reliability

DEVICE	I INPUTS	3-STATE O OUTPUTS	REGISTERED Q OUTPUTS	I/O PORT S
PAL20L8	14	2	0	6
PAL20R4	12	0	4 (3-state buffers)	4
PAL20R6	12	0	6 (3-state buffers)	2
PAL20R8	12	0	8 (3-state buffers)	0

(TOP VIEW) I 1 24 V <sub>CC</sub> I 2 23 I I 3 22 O I 4 21 I/O I 5 20 I/O I 6 19 I/O I 7 18 I/O I 8 17 I/O I 9 16 I/O I 10 15 O I 11 14 I GND 12 13 I TIBPAL20L8'	UFFIX JT OR NT PACKAGE M SUFFIX JT PACKAGE									
I    2    23    I      I    3    22    O      I    4    21    I/O      I    5    20    I/O      I    6    19    I/O      I    7    18    I/O      I    8    17    I/O      I    9    16    I/O      I    10    15    O      I    11    14    I      GND    12    13    I	(TOP VI	EW)								
TIBPAL20L8' C SUFFIX FN PACKAGE	3 4 5 6 7 8 9 10 11	23   I 22   O 21   I/O 20   I/O 19   I/O 18   I/O 17   I/O 16   I/O 15   O 14   I								

C SUFFIX ... FN PACKAGE M SUFFIX ... FK PACKAGE

(TOP VIEW)



NC – No internal connection Pin assignments in operating mode

#### description

These programmable array logic devices feature high speed and functional equivalency when compared with currently available devices. These IMPACT-X<sup>™</sup> circuits combine the latest Advanced Low-Power Schottky technology with proven titanium-tungsten fuses to provide reliable, high-performance substitutes for conventional TTL logic. Their easy programmability allows for quick design of custom functions and typically results in a more compact circuit board. In addition, chip carriers are available for futher reduction in board space.

All of the register outputs are set to a low level during power-up. Extra circuitry has been provided to allow loading of each register asynchronously to either a high or low state. This feature simplifies testing because the registers can be set to an initial state prior to executing the test sequence.

The TIBPAL20' C series is characterized from 0°C to 75°C. The TIBPAL20' M series is characterized for operation over the full military temperature range of -55°C to 125°C.

IMPACT-X is a trademark of Texas Instruments Incorporated. PAL is a registered trademark of Advanced Micro Devices Inc.

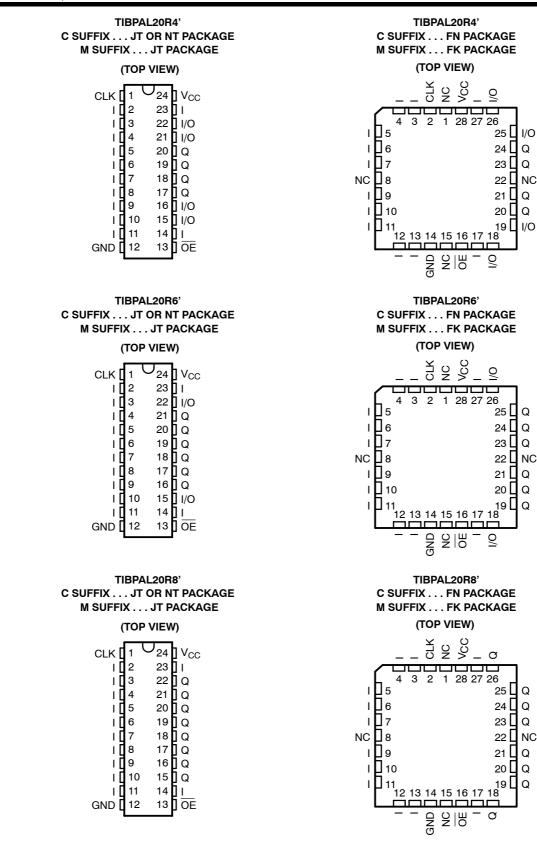
PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



#### **OBSOLETE** - No Longer Available

# TIBPAL20R4-7C, TIBPAL20R6-7C, TIBPAL20R8-7C TIBPAL20R4-10M, TIBPAL20R6-10M, TIBPAL20R8-10M HIGH-PERFORMÁNCE IMPACT-X TM PAL® CIRCUITS

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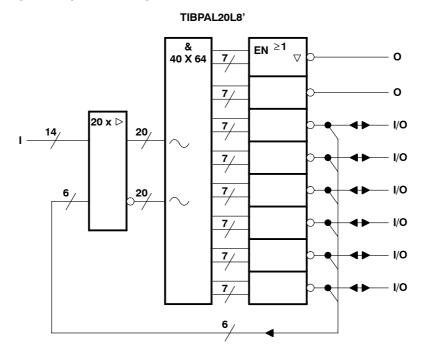
NC - No internal connection



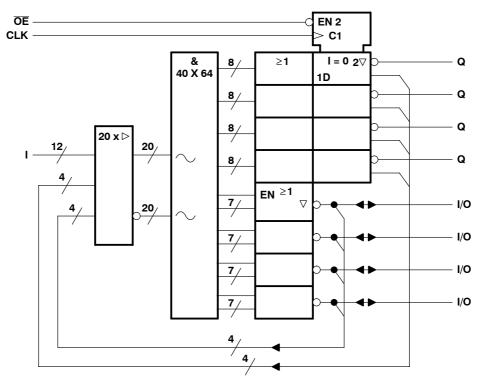
Pin assignments in operating mode

# TIBPAL20L8-7C, TIBPAL20R4-7C TIBPAL20L8-10M, TIBPAL20R4-10M HIGH-PERFORMANCE IMPACT-X TM PAL<sup>®</sup> CIRCUITS SRPS005E - D3307, OCTOBER 1989 - REVISED DECEMBER 2010

functional block diagrams (positive logic)



TIBPAL20R4'



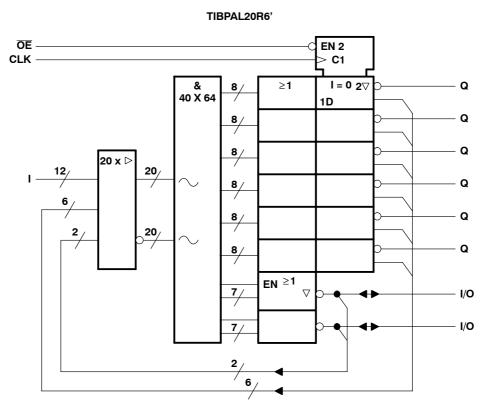
 $\bigcirc$  denotes fused inputs



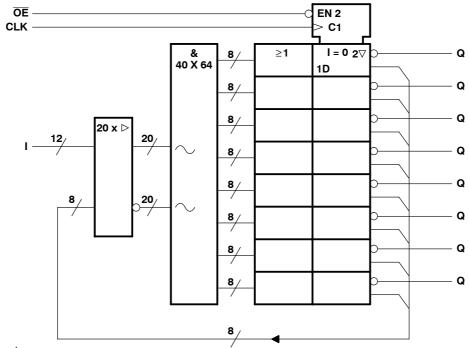
#### **OBSOLETE** - No Longer Available

# TIBPAL20R6-7C, TIBPAL20R8-7C TIBPAL20R6-10M, TIBPAL20R8-10M HIGH-PERFORMANCE IMPACT-X TM PAL<sup>®</sup> CIRCUITS SRPS005E – D3307, OCTOBER 1989 – REVISED DECEMBER 2010

#### functional block diagrams (positive logic)



TIBPAL20R8'

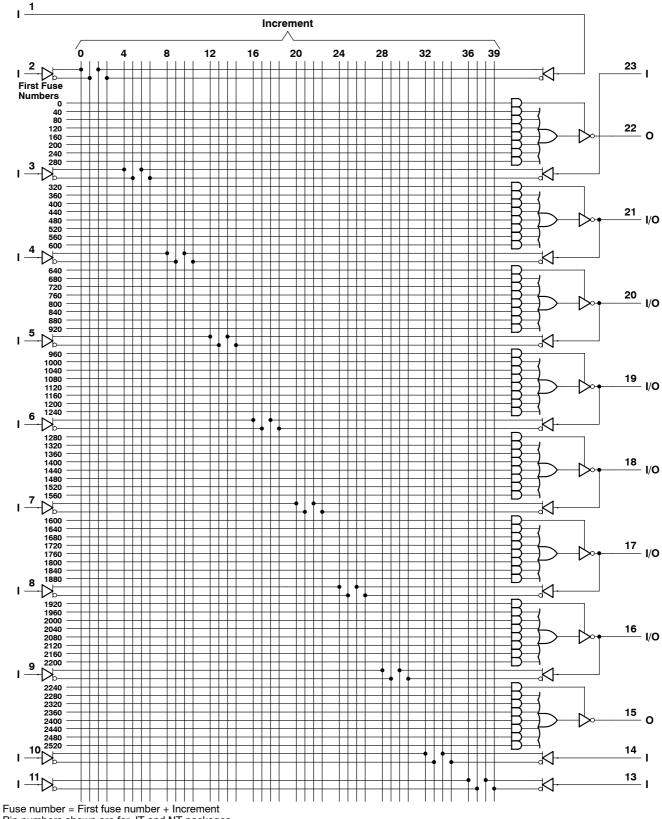


 $\bigcirc$  denotes fused inputs



TIBPAL20L8-7C TIBPAL20L8-10M HIGH-PERFORMANCE IMPACT-X TM PAL<sup>®</sup> CIRCUITS SRPS005E – D3307, OCTOBER 1989 – REVISED DECEMBER 2010

#### logic diagram (positive logic)

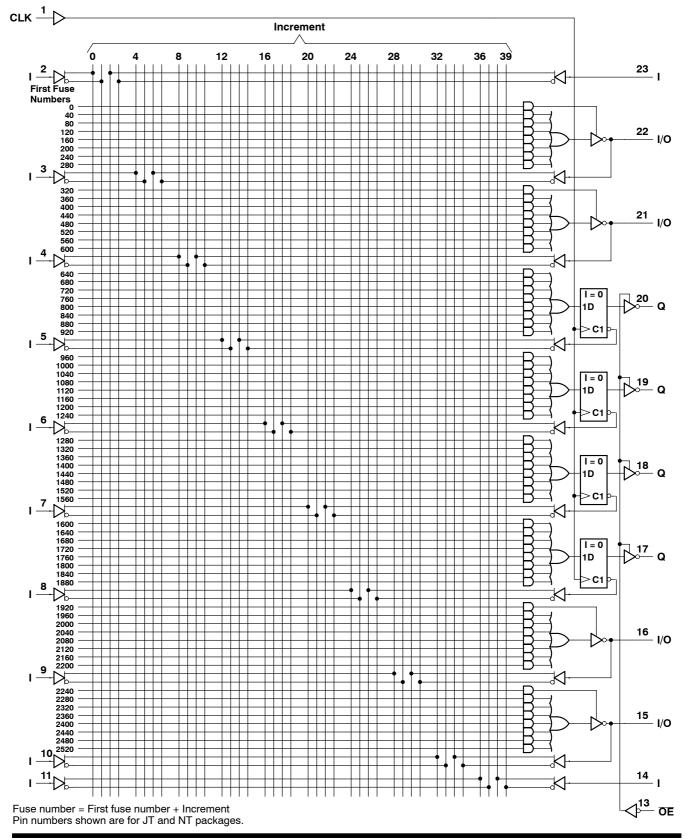


Pin numbers shown are for JT and NT packages.



# TIBPAL20R4-7C TIBPAL20R4-10M HIGH-PERFORMANCE IMPACT-X TM PAL<sup>®</sup> CIRCUITS

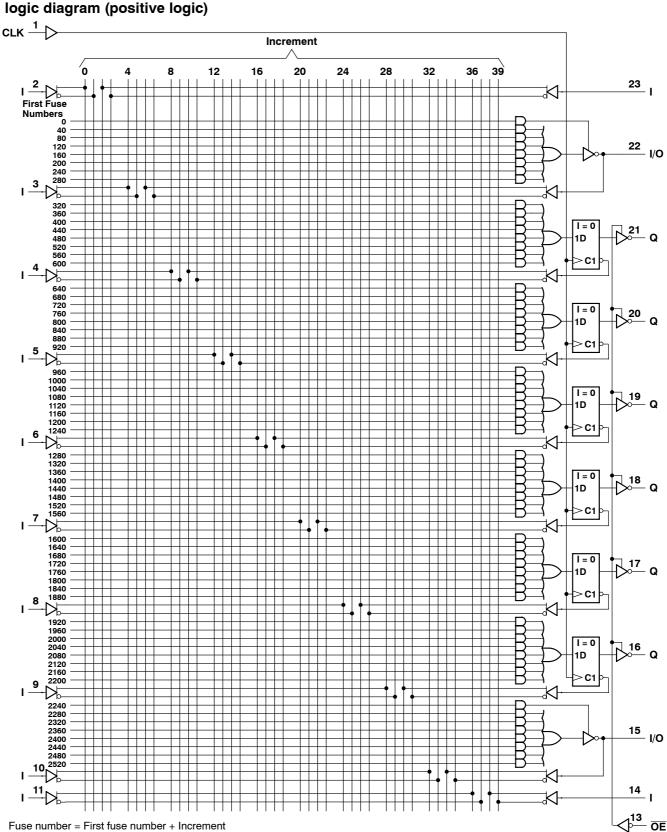
#### logic diagram (positive logic)





TIBPAL20R6-7C TIBPAL20R6-10M

HIGH-PERFORMANCE IMPACT-X TM PAL<sup>®</sup> CIRCUITS SRPS005E – D3307, OCTOBER 1989 – REVISED DECEMBER 2010

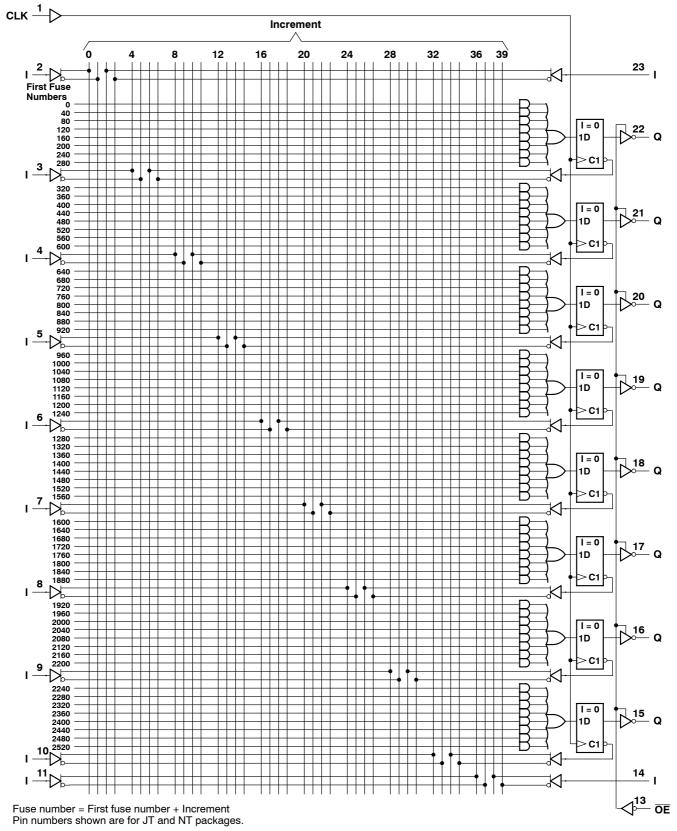


Pin numbers shown are for JT and NT packages.



# TIBPAL20R8-7C TIBPAL20R8-10M HIGH-PERFORMANCE IMPACT-X TM PAL<sup>®</sup> CIRCUITS

#### logic diagram (positive logic)





# OBSOLETE - No Longer Available TIBPAL20L8-7C, TIBPAL20R4-7C, TIBPAL20R6-7C, TIBPAL20R8-7C HIGH-PERFORMANCE *IMPACT-X* ™ *PAL*<sup>®</sup> CIRCUITS

SRPS005E - D3307, OCTOBER 1989 - REVISED DECEMBER 2010

#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V <sub>CC</sub> (see Note 1)	
Input voltage (see Note 1)	5.5 V
Voltage applied to disabled output (see Note 1)	5.5 V
Operating free-air temperature range	0°C to 75°C
Storage temperature range	–65°C to 150°C

NOTE 1: These ratings apply except for programming pins during a programming cycle.

#### recommended operating conditions

				MIN	NOM	MAX	UNIT
V <sub>CC</sub>	Supply voltage			4.75	5	5.25	V
VIH	High-level input voltage (see Note 2)			2		5.5	V
V <sub>IL</sub>	Low-level input voltage (see Note 2)					0.8	V
I <sub>OH</sub>	High-level output current					-3.2	mA
I <sub>OL</sub>	Low-level output current					24	mA
$f_{clock}^{\dagger}$	Clock frequency			0		100	MHz
t <sub>w</sub> †	Pulse duration, clock (see Note 2)	High		5			ns
w.	Tuise duration, clock (see Note 2)	Low		5			
t <sub>su</sub> †	Setup time, input or feedback before clock $\uparrow$	Setup time, input or feedback before clock↑					ns
t <sub>h</sub> †	Hold time, input or feedback after clock $\uparrow$			0			ns
T <sub>A</sub>	Operating free-air temperature			0	25	75	°C

 $^{\dagger}$  f\_{clock}, t\_{w}, t\_{su}, and t\_{h} do not apply for TIBPAL20L8'.

NOTE 2: These are absolute voltage levels with respect to the ground pin of the device and include all overshoots due to system and/or tester noise. Testing these parameters should not be attempted without suitable equipment.



# OBSOLETE - No Longer Available TIBPAL20L8-7C, TIBPAL20R4-7C, TIBPAL20R6-7C, TIBPAL20R8-7C HIGH-PERFORMANCE IMPACT-X ™ PAL<sup>®</sup> CIRCUITS

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#### electrical characteristics over recommended operating free-air temperature range

PARAMETER		TEST CONDITIONS		MIN	<b>TYP</b> <sup>†</sup>	MAX	UNIT
V <sub>IK</sub>	V <sub>CC</sub> = 4.75 V,	l <sub>l</sub> = – 18 mA			-0.8	-1.5	V
V <sub>OH</sub>	V <sub>CC</sub> = 4.75 V,	I <sub>OH</sub> = -3.2 mA		2.4	3.2		V
V <sub>OL</sub>	V <sub>CC</sub> = 4.75 V,	I <sub>OL</sub> = 24 mA			0.3	0.5	V
I <sub>OZH</sub> ‡	V <sub>CC</sub> = 5.25 V,	V <sub>O</sub> = 2.7 V				100	μA
I <sub>OZL</sub> ‡	V <sub>CC</sub> = 5.25 V,	V <sub>O</sub> = 0.4 V				-100	μA
I <sub>I</sub>	V <sub>CC</sub> = 5.25 V,	V <sub>I</sub> = 5.5 V				100	μA
IIH‡	V <sub>CC</sub> = 5.25 V,	V <sub>I</sub> = 2.7 V				25	μA
IIL‡	V <sub>CC</sub> = 5.25 V,	V <sub>I</sub> = 0.4 V			-80	-250	μA
I <sub>OS</sub> <sup>§</sup>	V <sub>CC</sub> = 5.25 V,	V <sub>O</sub> = 0.5 V		-30	-70	-130	mA
I <sub>CC</sub>	V <sub>CC</sub> = 5.25 V,	$V_{I} = 0,$	Outputs open		150	210	mA
C <sub>i</sub>	f = 1 MHz,	V <sub>I</sub> = 2 V			5		pF
Co	f = 1 MHz,	V <sub>O</sub> = 2 V			6		pF
C <sub>clk</sub>	f = 1 MHz,	$V_{CLK} = 2 V$			6		pF

# switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	FROM (INPUT)		TO (OUTPUT)	TEST CONDITION	MIN	TYP <sup>†</sup>	MAX	UNIT
	w	ithout fee	edback		100			
f <sub>max</sub> ¶			feedback ïguration)		100			MHz
	with	external	feedback		74			
÷	1.1/0	0, 1/0	1 or 2 outputs switching		3	5.5	7	ns
t <sub>pd</sub>	I, I/O	0, 1/0	8 outputs switching	R1 = 200 Ω,	3	6	7.5	115
t <sub>pd</sub>	CLK↑		Q	R2 = 390 Ω,	2	4	6.5	ns
t <sub>pd</sub> #	CLK↑		Feedback input	See Figure 6			3	ns
t <sub>en</sub>	OE↓		Q			4	7.5	ns
t <sub>dis</sub>	OE↑		Q			4	7.5	ns
t <sub>en</sub>	I, I/O	O, I/O				6	9	ns
t <sub>dis</sub>	I, I/O		0, I/0			6	9	ns
t <sub>sk(o)</sub>	Skew betv	veen reg	istered outputs			0.5		ns

 $^{\dagger}$  All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

 $^{\ddagger}$  I/O leakage is the worst case of  $I_{OZL}$  and  $I_{IL}$  or  $I_{OZH}$  and  $I_{IH}$  respectively.

<sup>§</sup> Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second. V<sub>O</sub> is set at 0.5 V to avoid test problems caused by test equipment ground degradation.

 ${}^{\P}$  See section for  $f_{max}$  specifications.

<sup>#</sup> This parameter applies to TIBPAL20R4' and TIBPAL20R6' only (see Figure 4 for illustration) and is calculated from the measured f<sub>max</sub> with internal feedback in the counter configuration.

<sup>||</sup> This parameter is the measurement of the difference between the fastest and slowest t<sub>pd</sub> (CLK-to-Q) observed when multiple registered outputs are switching in the same direction.



# OBSOLETE - No Longer Available TIBPAL20L8-10M, TIBPAL20R4-10M, TIBPAL20R6-10M, TIBPAL20R8-10M HIGH-PERFORMANCE IMPACT-X ™ PAL<sup>®</sup> CIRCUITS

SRPS005E - D3307, OCTOBER 1989 - REVISED DECEMBER 2010

#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V <sub>CC</sub> (see Note 1)	
Voltage applied to disabled output (see Note 1)	5.5 V -55°C to 125°C
Storage temperature range	–65°C to 150°C

NOTE 1: These ratings apply except for programming pins during a programming cycle.

#### recommended operating conditions

				MIN	NOM	MAX	UNIT
V <sub>CC</sub>	Supply voltage			4.5	5	5.5	V
V <sub>IH</sub>	High-level input voltage			2		5.5	V
V <sub>IL</sub>	Low-level input voltage					0.8	V
I <sub>OH</sub>	High-level output current					-2	mA
I <sub>OL</sub>	Low-level output current					12	mA
$f_{clock}^{\dagger}$	Clock frequency					62.5	MHz
t <sub>w</sub> †	Pulse duration, clock (see Note 2)	High		8			ns
'w'	Fulse duration, clock (see Note 2)	Low		8			113
t <sub>su</sub> †	Setup time, input or feedback before clock $\uparrow$	10			ns		
t <sub>h</sub> †	Hold time, input or feedback after clock $\uparrow$			0			ns
T <sub>A</sub>	Operating free-air temperature			-55	25	125	°C

 $^{\dagger}$   $f_{clock},$   $t_{w},$   $t_{su},$  and  $t_{h}$  do not apply for TIBPAL20L8'.

NOTE 2: These are absolute voltage levels with respect to the ground pin of the device and include all overshoots due to system and/or tester noise. Testing these parameters should not be attempted without suitable equipment.



## OBSOLETE - No Longer Available TIBPAL20L8-10M, TIBPAL20R4-10M, TIBPAL20R6-10M, TIBPAL20R8-10M HIGH-PERFORMANCE IMPACT-X ™ PAL<sup>®</sup> CIRCUITS

SRPS005E - D3307, OCTOBER 1989 - REVISED DECEMBER 2010

#### electrical characteristics over recommended operating free-air temperature range

PARAMETER		TEST CONDITIONS	М	IN TYP <sup>†</sup>	MAX	UNIT
V <sub>IK</sub>	V <sub>CC</sub> = 4.5 V,	I <sub>I</sub> = – 18 mA		-0.8	-1.5	V
V <sub>OH</sub>	V <sub>CC</sub> = 4.5 V,	I <sub>OH</sub> = -2 mA	2	2.4 3.2		V
V <sub>OL</sub>	V <sub>CC</sub> = 4.5 V,	I <sub>OL</sub> = 12 mA		0.3	0.5	V
I <sub>OZH</sub> ‡	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.7 V			20	μA
l <sub>OZL</sub> ‡	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 0.4 V			-0.1	mA
I <sub>I</sub>	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 5.5 V			1	mA
I <sub>IH</sub> ‡ I/O ports	$V_{CC} = 5.5 V,$	V <sub>1</sub> = 2.7 V			100	μA
All others	• 00 = 5.5 •,	v   - 2.7 v			25	μ
l <sub>IL</sub> ‡	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 0.4 V		-0.08	-0.25	mA
I <sub>OS</sub> §	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 0.5 V	-	30 –70	- 130	mA
I <sub>CC</sub>	V <sub>CC</sub> = 5.5 V, V <sub>I</sub> = 0,	Outputs open OE = V <sub>IH</sub>		140	220	mA
Ci	f = 1 MHz,	V <sub>I</sub> = 2 V		5		pF
Co	f = 1 MHz,	V <sub>O</sub> = 2 V		6		pF
C <sub>clk</sub>	f = 1 MHz,	V <sub>CLK</sub> = 2 V		6		pF

# switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITION	MIN	TYP†	MAX	UNIT
	without f	eedback		62.5			
f <sub>max</sub> ¶	f <sub>max</sub> <sup>¶</sup> with internal feedba (counter configurati			62.5			MHz
	with externa	al feedback		50			
t <sub>pd</sub>	I, I/O	O, I/O	R1 = 390 Ω,	1	6	10	ns
t <sub>pd</sub>	CLK↑	Q	R2 = 750 Ω,	1	4	10	ns
t <sub>pd</sub> #	CLK↑	Feedback input	See Figure 6			5	ns
t <sub>en</sub>	OE↓	Q		1	4	10	ns
t <sub>dis</sub>	OE↑	Q		1	4	10	ns
t <sub>en</sub>	I, I/O	0, I/O		1	6	12	ns
t <sub>dis</sub>	I, I/O	O, I/O		1	6	10	ns

 $^{\dagger}$  All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

 $^{\ddagger}$  I/O leakage is the worst case of  $I_{OZL}$  and  $I_{IL}$  or  $I_{OZH}$  and  $I_{IH}$  respectively.

§ Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second. V<sub>O</sub> is set at 0.5 V to avoid test problems caused by test equipment ground degradation.

<sup>1</sup> See section for f<sub>max</sub> specifications. f<sub>max</sub> with external feedback is not production tested but is calculated from the equation found in the f<sub>max</sub> specification section.

<sup>#</sup> This parameter applies to TIBPAL20R4' and TIBPAL20R6' only (see Figure 4 for illustration) and is calculated from the measured f<sub>max</sub> with internal feedback in the counter configuration.



#### OBSOLETE - No Longer Available TIBPAL20L8-7C, TIBPAL20R4-7C, TIBPAL20R6-7C, TIBPAL20R8-7C TIBPAL20L8-10M, TIBPAL20R4-10M, TIBPAL20R6-10M, TIBPAL20R8-10M HIGH-PERFORMANCE IMPACT-X TM PAL<sup>®</sup> CIRCUITS SRPS005E - D3307, OCTOBER 1989 - REVISED DECEMBER 2010

#### programming information

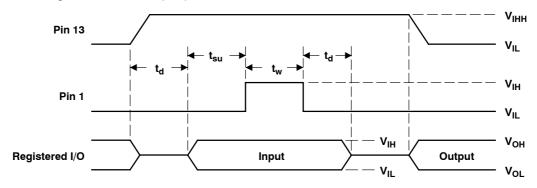
Texas Instruments programmable logic devices can be programmed using widely available software and inexpensive device programmers.

Complete programming specifications, algorithms, and the latest information on hardware, software, and firmware are available upon request. Information on programmers capable of programming Texas Instruments programmable logic is also available, upon request, from the nearest TI field sales office, local authorized TI distributor, or by calling Texas Instruments at (214) 997-5666.

#### preload procedure for registered outputs (see Figure 1 and Note 3)

The output registers can be preloaded to any desired state during device testing. This permits any state to be tested without having to step through the entire state-machine sequence. Each register is preloaded individually by following the steps given below.

- Step 1. With V<sub>CC</sub> at 5 volts and Pin 1 at V<sub>IL</sub>, raise Pin 13 to V<sub>IHH</sub>.
- Step 2. Apply either V<sub>IL</sub> or V<sub>IH</sub> to the output corresponding to the register to be preloaded.
- Step 3. Pulse Pin 1, clocking in preload data.
- Step 4. Remove output voltage, then lower Pin 13 to V<sub>IL</sub>. Preload can be verified by observing the voltage level at the output pin.



#### Figure 1. Preload Waveforms

NOTE 3:  $t_d = t_{su} = t_h = 100$  ns to 1000 ns V<sub>IHH</sub> = 10.25 V to 10.75 v

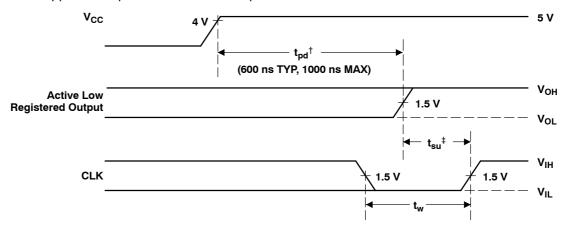


# OBSOLETE - No Longer Available TIBPAL20L8-7C, TIBPAL20R4-7C, TIBPAL20R6-7C, TIBPAL20R8-7C TIBPAL20L8-10M, TIBPAL20R4-10M, TIBPAL20R6-10M, TIBPAL20R8-10M HIGH-PERFORMANCE *IMPACT-X* ™ *PAL*<sup>®</sup> CIRCUITS

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#### power-up reset (see Figure 2)

Following power up, all registers are reset to zero. This feature provides extra flexibility to the system designer and is especially valuable in simplifying state-machine initialization. To ensure a valid power-up reset, it is important that the rise of  $V_{CC}$  be monotonic. Following power-up reset, a low-to-high clock transition must not occur until all applicable input and feedback setup times are met.



<sup>†</sup> This is the power-up reset time and applies to registered outputs only. The values shown are from characterization data.

<sup>‡</sup> This is the setup time for input or feedback.

Figure 2. Power-Up Reset Waveforms



#### OBSOLETE - No Longer Available TIBPAL20L8-7C, TIBPAL20R4-7C, TIBPAL20R6-7C, TIBPAL20R8-7C TIBPAL20L8-10M, TIBPAL20R4-10M, TIBPAL20R6-10M, TIBPAL20R8-10M HIGH-PERFORMANCE IMPACT-X ™ PAL<sup>®</sup> CIRCUITS SRPS005E - D3307, OCTOBER 1989 - REVISED DECEMBER 2010

#### f<sub>max</sub> SPECIFICATIONS

#### f<sub>max</sub> without feedback, see Figure 3

In this mode, data is presented at the input to the flip-flop and clocked through to the Q output with no feedback. Under this condition, the clock period is limited by the sum of the data setup time and the data hold time  $(t_{su} + t_h)$ . However, the minimum  $f_{max}$  is determined by the minimum clock period  $(t_w \text{ high } + t_w \text{ low})$ .

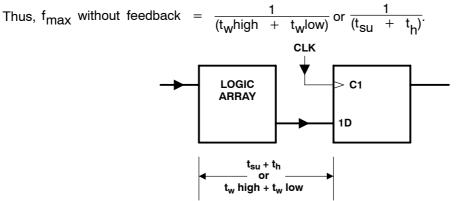


Figure 3. f<sub>max</sub> Without Feedback

#### fmax with internal feedback, see Figure 4

This configuration is most popular in counters and on-chip state-machine designs. The flip-flop inputs are defined by the device inputs and flip-flop outputs. Under this condition, the period is limited by the internal delay from the flip-flop outputs through the internal feedback and logic array to the inputs of the next flip-flop.

Thus, 
$$f_{max}$$
 with internal feedback =  $\frac{1}{(t_{su} + t_{pd} CLK - to - FB)}$ .

Where tpd CLK-to-FB is the deduced value of the delay from CLK to the input of the logic array.

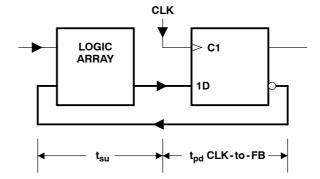


Figure 4. f<sub>max</sub> With Internal Feedback



# **OBSOLETE** - No Longer Available TIBPAL20L8-7C, TIBPAL20R4-7C, TIBPAL20R6-7C, TIBPAL20R8-7C TIBPAL20L8-10M, TIBPAL20R4-10M, TIBPAL20R6-10M, TIBPAL20R8-10M HIGH-PERFORMANCE IMPACT-X TM PAL® CIRCUITS

SRPS005E - D3307, OCTOBER 1989 - REVISED DECEMBER 2010

#### fmax SPECIFICATIONS

#### fmax with external feedback, see Figure 5

This configuration is a typical state-machine design with feedback signals sent off-chip. This external feedback could go back to the device inputs or to a second device in a multi-chip state machine. The slowest path defining the period is the sum of the clock-to-output time and the input setup time for the external signals (t<sub>su</sub> + t<sub>pd</sub> CLK-to-Q).

Thus, fmax with external feedback =

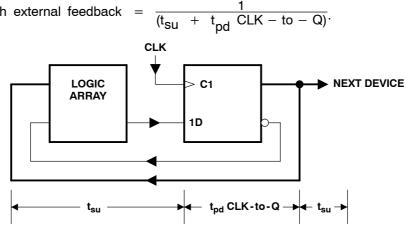
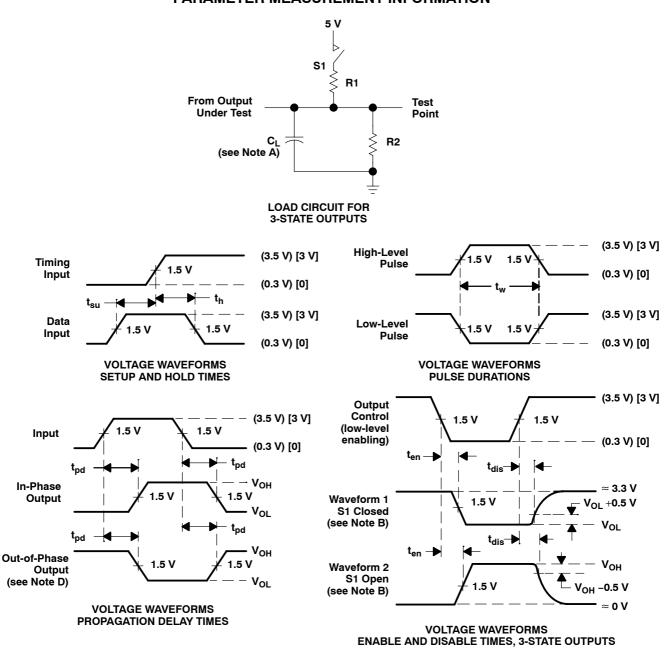


Figure 5. f<sub>max</sub> With External Feedback



# OBSOLETE - No Longer Available TIBPAL20L8-7C, TIBPAL20R4-7C, TIBPAL20R6-7C, TIBPAL20R8-7C TIBPAL20L8-10M, TIBPAL20R4-10M, TIBPAL20R6-10M, TIBPAL20R8-10M HIGH-PERFORMANCE IMPACT-X ™ PAL<sup>®</sup> CIRCUITS

SRPS005E - D3307, OCTOBER 1989 - REVISED DECEMBER 2010



PARAMETER MEASUREMENT INFORMATION

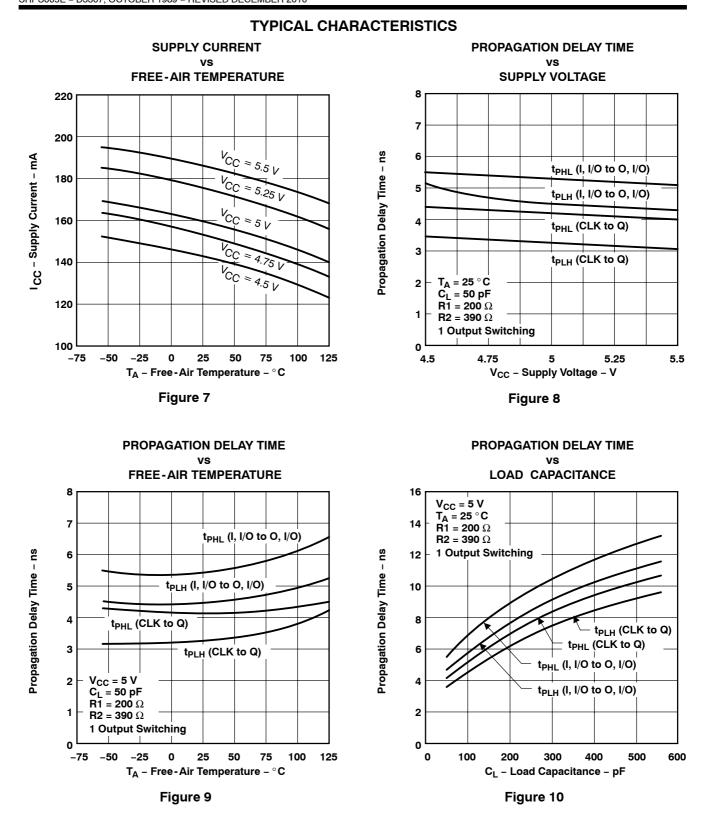
- NOTES: A.  $C_L$  includes probe and jig capacitance and is 50 pF for  $t_{pd}$  and  $t_{en}$ , 5 pF for  $t_{dis}$ .
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - C. All input pulses have the following characteristics: PRR  $\leq$  10 MHz, t<sub>r</sub> and t<sub>f</sub>  $\leq$  2 ns, duty cycle = 50%. For C suffix, use the voltage levels indicated inparentheses ( ). For M suffix, use the voltage levels indicated in brackets [ ].
  - D. When measuring propagation delay times of 3-state outputs, switch S1 is closed.
  - E. Equivalent loads may be used for testing.

#### Figure 6. Load Circuit and Voltage Waveforms



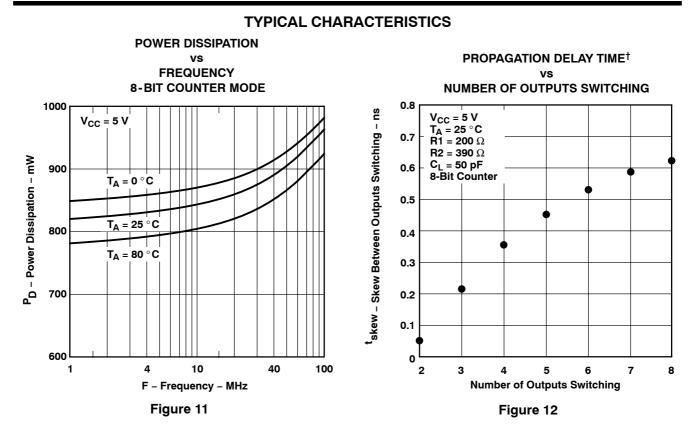
#### OBSOLETE - No Longer Available

TIBPAL20L8-7C, TIBPAL20R4-7C, TIBPAL20R6-7C, TIBPAL20R8-7C TIBPAL20L8-10M, TIBPAL20R4-10M, TIBPAL20R6-10M, TIBPAL20R8-10M HIGH-PERFORMANCE IMPACT-X TM PAL<sup>®</sup> CIRCUITS SRPS005E - D3307, OCTOBER 1989 - REVISED DECEMBER 2010





#### OBSOLETE - No Longer Available TIBPAL20L8-7C, TIBPAL20R4-7C, TIBPAL20R6-7C, TIBPAL20R8-7C TIBPAL20L8-10M, TIBPAL20R4-10M, TIBPAL20R6-10M, TIBPAL20R8-10M HIGH-PERFORMANCE IMPACT-X ™ PAL<sup>®</sup> CIRCUITS SRPS005E - D3307, OCTOBER 1989 - REVISED DECEMBER 2010



**PROPAGATION DELAY TIME** vs NUMBER OF OUTPUTS SWITCHING 8 7 t<sub>PHL</sub> (I, I/O to O, I/O) Propagation Delay Time – ns 6 t<sub>PI H</sub> (I, I/O to O, I/O) 5 t<sub>PHL</sub> (CLK to Q) 4 t<sub>PLH</sub> (CLK to Q) 3 2  $V_{CC} = 5 V$ T<sub>A</sub> = 25 °C  $C_L = 50 \text{ pF}$ 1 **R**1 = 200 Ω **R2 = 390** Ω 0 0 1 2 3 4 5 6 7 8 Number of Outputs Switching

Figure 13

<sup>†</sup>Outputs switching in the same direction (t<sub>PLH compared to</sub> t<sub>PLH</sub>/t<sub>PHL to</sub> t<sub>PHL</sub>)





17-Dec-2015

## **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
5962-87671153A	OBSOLETE	LCCC	FK	28		TBD	Call TI	Call TI	-55 to 125		
5962-8767115KA	OBSOLETE	E CFP	W	24		TBD	Call TI	Call TI	-55 to 125		
5962-8767115LA	OBSOLETE	CDIP	JT	24		TBD	Call TI	Call TI	-55 to 125		
5962-87671163A	OBSOLETE	LCCC	FK	28		TBD	Call TI	Call TI	-55 to 125		
5962-8767116KA	OBSOLETE	CFP	W	24		TBD	Call TI	Call TI	-55 to 125		
5962-8767116LA	OBSOLETE	CDIP	JT	24		TBD	Call TI	Call TI	-55 to 125		
5962-87671173A	OBSOLETE	LCCC	FK	28		TBD	Call TI	Call TI	-55 to 125		
5962-8767117KA	OBSOLETE	CFP	W	24		TBD	Call TI	Call TI	-55 to 125		
5962-8767117LA	OBSOLETE	CDIP	JT	24		TBD	Call TI	Call TI	-55 to 125		
5962-87671183A	OBSOLETE	LCCC	FK	28		TBD	Call TI	Call TI	-55 to 125		
5962-8767118KA	OBSOLETE	CFP	W	24		TBD	Call TI	Call TI	-55 to 125		
5962-8767118LA	OBSOLETE	CDIP	JT	24		TBD	Call TI	Call TI	-55 to 125		
TIBPAL20L8-10MFKB	OBSOLETE	LCCC	FK	28		TBD	Call TI	Call TI	-55 to 125	5962- 87671153A TIBPAL20 L8-10MFKB	
TIBPAL20L8-10MJTB	OBSOLETE	CDIP	JT	24		TBD	Call TI	Call TI	-55 to 125	5962-8767115LA TIBPAL20L8-10M JTB	
TIBPAL20L8-10MWB	OBSOLETE	CFP	W	24		TBD	Call TI	Call TI	-55 to 125	5962-8767115KA TIBPAL20L8-10M WB	
TIBPAL20L8-7CFN	OBSOLETE	PLCC	FN	28		TBD	Call TI	Call TI	0 to 75		
TIBPAL20L8-7CNT	OBSOLETE	PDIP	NT	24		TBD	Call TI	Call TI	0 to 75		
TIBPAL20R4-10MFKB	OBSOLETE	LCCC	FK	28		TBD	Call TI	Call TI	-55 to 125	5962- 87671183A TIBPAL20 R4-10MFKB	
TIBPAL20R4-10MJTB	OBSOLETE	CDIP	JT	24		TBD	Call TI	Call TI	-55 to 125	5962-8767118LA TIBPAL20R4-10M JTB	
TIBPAL20R4-10MWB	OBSOLETE	CFP	W	24		TBD	Call TI	Call TI	-55 to 125	5962-8767118KA TIBPAL20R4-10M	



# PACKAGE OPTION ADDENDUM

17-Dec-2015

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
										WB	
TIBPAL20R4-7CFN	OBSOLETE	PLCC	FN	28		TBD	Call TI	Call TI	0 to 75		
TIBPAL20R4-7CNT	OBSOLETE	E PDIP	NT	24		TBD	Call TI	Call TI	0 to 75		
TIBPAL20R6-10MFKB	OBSOLETE	LCCC	FK	28		TBD	Call TI	Call TI	-55 to 125	5962- 87671173A TIBPAL20 R6-10MFKB	
TIBPAL20R6-10MJTB	OBSOLETE	CDIP	JT	24		TBD	Call TI	Call TI	-55 to 125	5962-8767117LA TIBPAL20R6-10M JTB	
TIBPAL20R6-10MWB	OBSOLETE	CFP	W	24		TBD	Call TI	Call TI	-55 to 125	5962-8767117KA TIBPAL20R6-10M WB	
TIBPAL20R6-7CFN	OBSOLETE	PLCC	FN	28		TBD	Call TI	Call TI	0 to 75	20R6-7CFN	
TIBPAL20R6-7CNT	OBSOLETE	PDIP	NT	24		TBD	Call TI	Call TI	0 to 75	TIBPAL20R6-7CN T	
TIBPAL20R8-10MFKB	OBSOLETE	LCCC	FK	28		TBD	Call TI	Call TI	-55 to 125		
TIBPAL20R8-10MJTB	OBSOLETE	CDIP	JT	24		TBD	Call TI	Call TI	-55 to 125		
TIBPAL20R8-10MWB	OBSOLETE	CFP	W	24		TBD	Call TI	Call TI	-55 to 125		

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.



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<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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# **MECHANICAL DATA**

MCER004A - JANUARY 1995 - REVISED JANUARY 1997

## JT (R-GDIP-T\*\*)

#### **CERAMIC DUAL-IN-LINE**

24 LEADS SHOWN



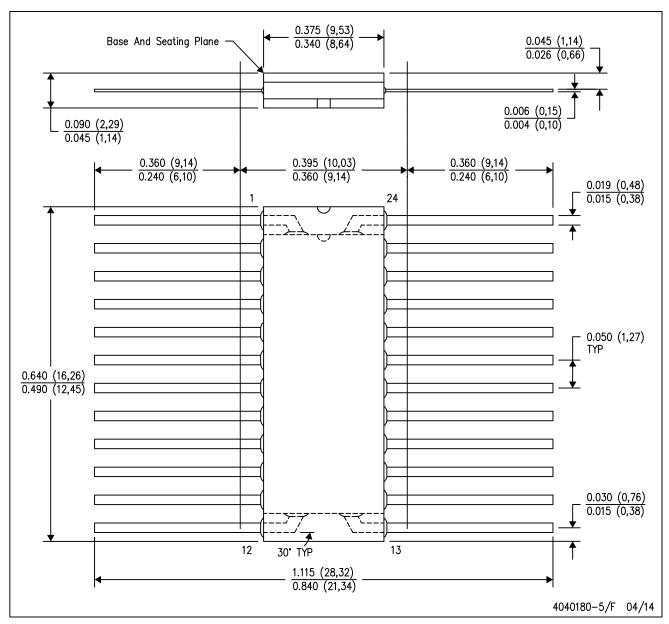
NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification.
- E. Falls within MIL STD 1835 GDIP3-T24, GDIP4-T28, and JEDEC MO-058 AA, MO-058 AB



CERAMIC DUAL FLATPACK

W (R-GDFP-F24)



NOTES: A. All linear dimensions are in inches (millimeters).

- This drawing is subject to change without notice. В.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only.
  E. Falls within Mil-Std 1835 GDFP2-F20



LEADLESS CERAMIC CHIP CARRIER

FK (S-CQCC-N\*\*) 28 TERMINAL SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. This package can be hermetically sealed with a metal lid.

D. Falls within JEDEC MS-004



NT (R-PDIP-T\*\*) 24 pins shown

PLASTIC DUAL-IN-LINE PACKAGE



All integrations are in minimeters. Dimensioning and toil
 B. This drawing is subject to change without notice.

The 28 pin end lead shoulder width is a vendor option, either half or full width.



# **MECHANICAL DATA**

MPLC004A - OCTOBER 1994

#### PLASTIC J-LEADED CHIP CARRIER

## FN (S-PQCC-J\*\*)



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Falls within JEDEC MS-018



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